

Notice of References Cited	Application/Control No. 10/579,565		Applicant(s)/Patent Under Reexamination HYDE ET AL.	
	Examiner Hai C. Pham		Art Unit 2861	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-5,909,232	06-1999	Goto et al.	347/187
*	B	US-6,633,319	10-2003	Yamakawa et al.	347/172
*	C	US-7,256,803	08-2007	Hilbert, John	347/171
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	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

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NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
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